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# Modeling of electronic properties of interfaces in solar cells

WIS

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Domain of Expertise: Electronic devices

### **Background**

Photovoltaic cells are semiconductor heterostructures

Effects of rough interfaces in thin-film cells:

- used for light trapping, have strong impact on the functionality of the device
- nanoscale-treatment of interfaces to tune electronic properties

Helmholtz-Zentrum Berlin für Materialien und Energie investigates thin-film

- a-Si:H/c-Si solar cells built from layers of amorphous and crystalline silicon Issues: reduction of recombination losses at the a-Si:H/c-Si interface
  - improvement of the charge-carrier transport over the heterointerface

#### Technological aims in photovoltaics:

- maximize efficiency of the solar cells
- minimize production costs, ...

#### Principle of solar cells:

- photons generate electron-hole pairs
- electrons/holes move to contacts
- → minimize recombination losses

#### At heterointerfaces new electrical effects may occur:

- electrons, holes are transmitted/reflected
- technological treatment of interfaces leads to defect distributions
- special recombination at defects
- quantum mechanical tunneling effects

at defects

unneling effects

 $\sim$  new mathematical models required!

# **Equations in the bulk**

$$\begin{split} \frac{\partial}{\partial t} n - \operatorname{div} \! \left( c_n (\nabla n - n \nabla \varphi) \right) &= G_{\mathrm{phot}} (t, x) - \left\langle \left\langle \rho_n (.., n, \eta) \right\rangle \right\rangle - R(n, p), \\ \frac{\partial}{\partial t} p - \operatorname{div} \! \left( c_p (\nabla p + p \nabla \varphi) \right) &= G_{\mathrm{phot}} (t, x) - \left\langle \left\langle \rho_p (.., p, \eta) \right\rangle \right\rangle - R(n, p), \\ - \operatorname{div} \! \left( \varepsilon(x) \nabla \varphi \right) &= d_{\mathrm{dop}} (x) + p - n - \left\langle \left\langle \eta \right\rangle \right\rangle \\ \frac{\partial}{\partial t} \eta(t, x, E) &= \rho_n (x, E, n, \eta) - \rho_p (x, E, p, \eta) \end{split}$$

 $egin{aligned} n, \ p \ arphi, \ \eta \ R(n,p), \ G_{ extstyle phot} \ 
ho_n, \ 
ho_p \end{aligned}$ 

densities of electrons and holes electrostatic potential, defect-occupation probability recombination rate, optical generation rate ionization rates of defects

$$\langle\langle g\rangle\rangle := \int_{E_{\mathrm{V}}}^{E_{\mathrm{C}}} \,g(E) N(x,\!E)\,\mathrm{d}E,$$

E energy levels

# Research plan for the project

#### (1) Nontrivial interface conditions

Conditions at interfaces  $x^{\mathrm{I}} = x = x^{\mathrm{II}}$ 

• extra defect dynamics ( $\widehat{\eta}$  localized at interface x)

$$\begin{split} \frac{\partial}{\partial t} \widehat{\eta}(t, x, E) &= \rho_n(x^{\mathrm{I}}, E, n^{\mathrm{I}}, \widehat{\eta}) + \rho_n(x^{\mathrm{II}}, E, n^{\mathrm{II}}, \widehat{\eta}) \\ &- \rho_p(x^{\mathrm{I}}, E, p^{\mathrm{I}}, \widehat{\eta}) - \rho_p(x^{\mathrm{II}}, E, p^{\mathrm{II}}, \widehat{\eta}) \end{split}$$

current determined by thermionic emission and defect recombination

$$c_n(\nabla n - n\nabla\varphi)^{\mathrm{I}} \cdot \nu = \alpha_n^{\mathrm{I}} n^{\mathrm{I}} - \alpha_n^{\mathrm{II}} n^{\mathrm{II}} + \langle \langle \rho_n(x^{\mathrm{I}}, \cdot, n^{\mathrm{I}}, \widehat{\eta}) \rangle \rangle$$

(plus 3 similar conditions)

#### Aims:

- thermodynamic wellposedness of resulting model equations
- existence theory for stationary/instationary problems (starting from lower dimensional problems)

#### (2) Approximation by pseudo layers

Numerical implementations replace the interface conditions and the interface-trap kinetics by bulk kinetics on thin layer elements with suitably scaled properties

- (++) classical interface conditions can be used
- (--) the problem might become badly conditioned or even unstable

#### Aims:

- Investigate this approximation procedure in a rigorous fashion
- Which nontrivial boundary conditions can be obtained by such limits?
   How much freedom do we have in such approximations?
- Approximate tunneling effects through interfacial potential barriers:

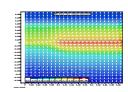
Do pseudo-layers with fitted material data approximate the tunneling characteristics sufficiently well?

# (3) Numerical approximation and simulation

1-dimensional software AFORS-HET of Helmholtz Zentrum Berlin (HZB) uses finite differences, no numerical analysis available

#### Aims

- establish discretization schemes benefitting from analytical properties of the continuous problem
- implement such schemes or adapt WIAS-TeSCA
- predict characteristics of solar cells (band diagrams, cv-characteristics, quantum efficiency)
- validation/comparison with measurements (HZB)



WIAS-TeSCA Simulation (R. Nürnberg): Electron current through a structured passivation layer and electrostatic potential in a thin-film solar cell.

#### Cooperation

Helmholtz Zentrum Berlin für Materialien und Energie, Group SE1 "Silizium-Photovoltaik" (discussion of models, experimental data to validate our models) PVcomB: Photovoltaics Competence Center Berlin (Head Prof. Bernd Rech) ODERSUN AG Berlin · Frankfurt (Oder) · London (modeling and simulation)

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